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1. SCOPE

This specification shall cover the characteristics of 1-port SAW resonator with used for remote-control security.

2. ELECTRICAL SPECIFICATION

	DC Voltage VDC	7 10V
	AC Voltage Vpp	10V50Hz/60Hz
	Operation temperature	-20°℃ to +70°℃
	Storage temperature	-40°C to +85°C
	RF Power Dissipation	0dBm

2.2Electronic Characteristics

RF Power	Dissipation	0dBm			
2 2Electro	nic Characteristics				
Item		Unites	Minimum	Typical	Maximum
Center Freque	ncy	MHz	314.925	315	315.075
Insertion Loss	- ZF	dB		1.5	2.5
Quality Factor	r Unload Q		5000	12800	
50Ω Loaded Q			1000	2000	-21
Temperature	Turnover Temperature	°C	10	25	40
Stability	Freq.temp.Coefficient	ppm/°C2		0.032	
Frequency Ag	ing	ppm/yr	S/N	<±10	
DC. Insulation	n Resistance	MΩ	1.0		
	Motional Resistance R1	Ω	CE X	19	26
RF Equivaler	t Motional Inductance L1	μH	33	92.929	
KLC WIODEI	Motional Capacitance C1	fF		1.4475	
Transducer Static Capacitance		pF		1.95	

3. TEST CIRCUIT



4. DIMENSION



5. ENVIRONMENTAL CHARACTERISTICS

5-1 High temperature exposure

Subject the device to $+85^{\circ}$ C for 16 hours. Then release the resonator into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2.2.

5-2 Low temperature exposure

Subject the device to -40 °C for 16 hours. Then release the device into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2.2.

5-3 Temperature cycling

Subject the device to a low temperature of $-45 \,^{\circ}\text{C}$ for 30 minutes. Following by a high temperature of $+85 \,^{\circ}\text{C}$ for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in 2.2.

5-4 Resistance to solder heat

Dip the device terminals no closer than 1.5mm into the solder bath at 260° C $\pm 10^{\circ}$ C for 10 ± 1 sec. Then release the device into the room conditions for 4 hours. The device shall meet the specifications in 2.2.

5-5 Solderability

Subject the device terminals into the solder bath at $245 \,^{\circ}\text{C} \pm 5 \,^{\circ}\text{C}$ for 5s, More than 95% area of the terminals must be covered with new solder. It shall meet the specifications in 2.2.

5-6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in 2.2.

5-7 Vibration

Subject the device to the vibration for 1 hour each in x,y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in 2.2.

6. REMARK

6.1 Static voltage

Static voltage between signal load & ground may cause deterioration & destruction of the component. Please avoid static voltage.

6.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

6.3 Soldering

Only leads of component may be soldered. Please avoid soldering another part of component.

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